

ADC12DC105

Dual 12-Bit, 105 MSPS A/D Converter with CMOS Outputs

General Description

The ADC12DC105 is a high-performance CMOS analog-to-digital converter capable of converting two analog input signals into 12-bit digital words at rates up to 105 Mega Samples Per Second (MSPS). These converters use a differential, pipelined architecture with digital error correction and an on-chip sample-and-hold circuit to minimize power consumption and the external component count, while providing excellent dynamic performance. A unique sample-and-hold stage yields a full-power bandwidth of 1 GHz. The ADC12DC080/105 may be operated from a single +3.0V or +3.3V power supply. A power-down feature reduces the power consumption to very low levels while still allowing fast wake-up time to full operation. The differential inputs provide a 2V full scale differential input swing. A stable 1.2V internal voltage reference is provided, or the ADC12DC105 can be operated with an external 1.2V reference. Output data format (offset binary versus 2's complement) and duty cycle stabilizer are pin-selectable. The duty cycle stabilizer maintains performance over a wide range of clock duty cycles.

The ADC12DC105 is available in a 60-lead LLP package and operates over the industrial temperature range of -40°C to $+85^{\circ}\text{C}$.

Features

- Internal sample-and-hold circuit and precision reference
- Low power consumption
- Clock Duty Cycle Stabilizer
- Single +3.0V or +3.3V supply operation
- Power-down mode
- Offset binary or 2's complement output data format
- 60-pin LLP package, (9x9x0.8mm, 0.5mm pin-pitch)

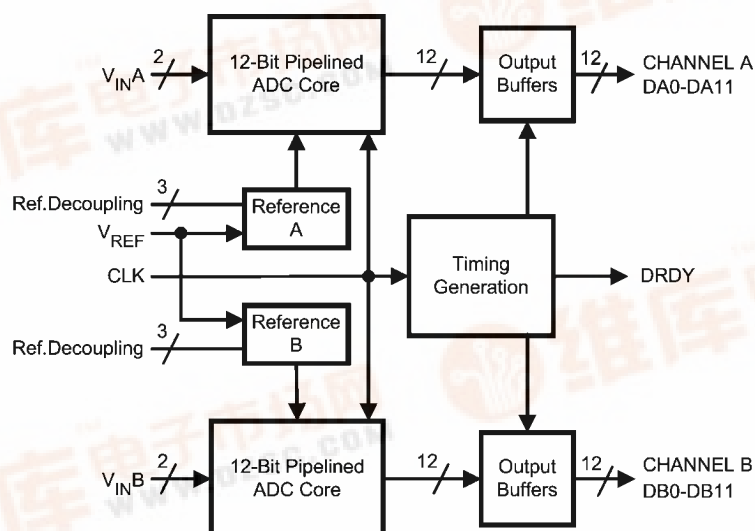
Key Specifications

■ Resolution	12 Bits
■ Conversion Rate	105 MSPS
■ SNR ($f_{\text{IN}} = 170 \text{ MHz}$)	69 dBFS (typ)
■ SFDR ($f_{\text{IN}} = 170 \text{ MHz}$)	83 dBFS (typ)
■ Full Power Bandwidth	1 GHz (typ)
■ Power Consumption	690 mW (typ), $V_A = 3.0\text{V}$
■	800 mW (typ), $V_A = 3.3\text{V}$

Applications

- High IF Sampling Receivers
- Wireless Base Station Receivers
- Test and Measurement Equipment
- Communications Instrumentation
- Portable Instrumentation

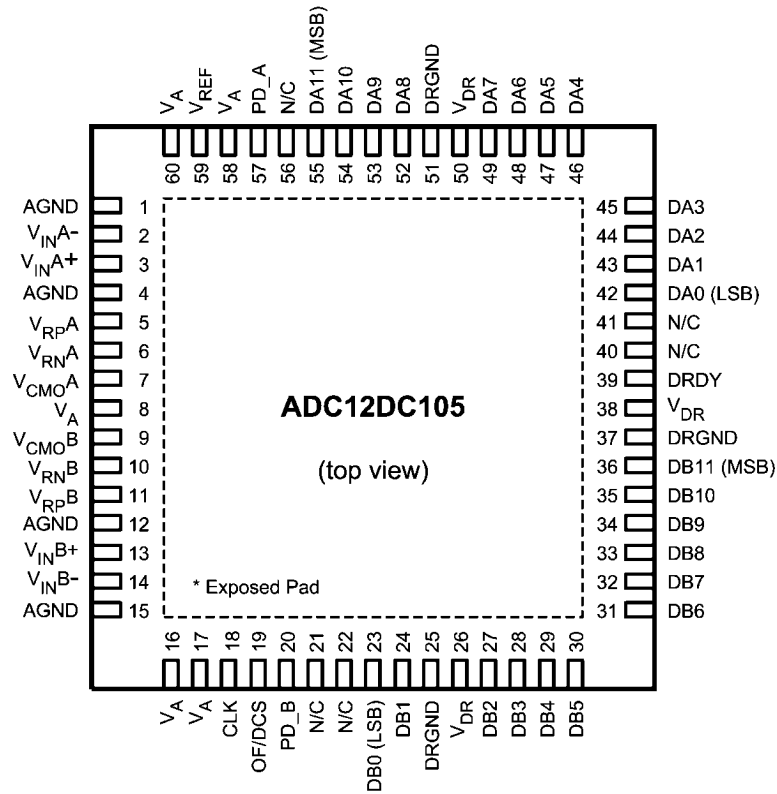
Block Diagram



30073902

Connection Diagram

[查询"ADC12DC105"供应商](#)



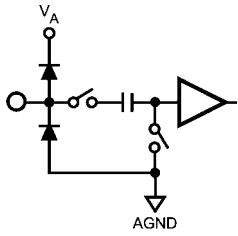
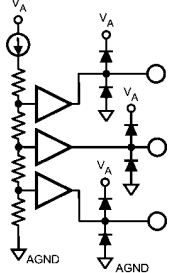
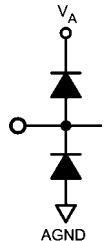
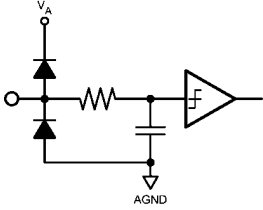
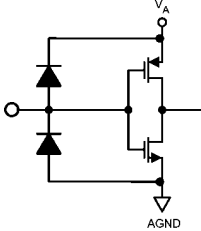
30073901

Ordering Information

Industrial ($-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$)	Package
ADC12DC105CISQ	60 Pin LLP
ADC12DC105CISQE	60 Pin LLP, 250 pc. Tape and Reel
ADC12DC105LFEB	Evaluation Board

Pin Descriptions and Equivalent Circuits

查询"ADC12DC105"供应商

Pin No.	Symbol	Equivalent Circuit	Description
ANALOG I/O			
3 13	$V_{IN}A+$ $V_{IN}B+$		Differential analog input pins. The differential full-scale input signal level is $2V_{P-P}$ with each input pin signal centered on a common mode voltage, V_{CM} .
2 14	$V_{IN}A-$ $V_{IN}B-$		
5 11	$V_{RP}A$ $V_{RP}B$		These pins should each be bypassed to AGND with a low ESL (equivalent series inductance) $0.1\ \mu F$ capacitor placed very close to the pin to minimize stray inductance. An 0201 size $0.1\ \mu F$ capacitor should be placed between V_{RP} and V_{RN} as close to the pins as possible, and a $1\ \mu F$ capacitor should be placed in parallel. V_{RP} and V_{RN} should not be loaded. V_{CMO} may be loaded to 1mA for use as a temperature stable 1.5V reference. It is recommended to use V_{CMO} to provide the common mode voltage, V_{CM} , for the differential analog inputs.
7 9	$V_{CMO}A$ $V_{CMO}B$		
6 10	$V_{RN}A$ $V_{RN}B$		
59	V_{REF}		Reference Voltage. This device provides an internally developed 1.2V reference. When using the internal reference, V_{REF} should be decoupled to AGND with a $0.1\ \mu F$ and a $1\ \mu F$, low equivalent series inductance (ESL) capacitor. This pin may be driven with an external 1.2V reference voltage. This pin should not be used to source or sink current when the internal reference is used.
DIGITAL I/O			
19	OF/DCS		This is a four-state pin controlling the input clock mode and output data format. OF/DCS = V_A , output data format is 2's complement without duty cycle stabilization applied to the input clock. OF/DCS = AGND, output data format is offset binary, without duty cycle stabilization applied to the input clock. OF/DCS = $(2/3)V_A$, output data is 2's complement with duty cycle stabilization applied to the input clock. OF/DCS = $(1/3)V_A$, output data is offset binary with duty cycle stabilization applied to the input clock.
18	CLK		The clock input pin. The analog inputs are sampled on the rising edge of the clock input.
57 20	PD_A PD_B		This is a two-state input controlling Power Down. PD = V_A , Power Down is enabled and power dissipation is reduced. PD = AGND, Normal operation.

Absolute Maximum Ratings (Notes 1, 3)

查询"ADC12DC105"供应商
If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V_A , V_{DR})	-0.3V to 4.2V
Voltage on Any Pin (Not to exceed 4.2V)	-0.3V to ($V_A + 0.3V$)
Input Current at Any Pin other than Supply Pins (Note 4)	± 5 mA
Package Input Current (Note 4)	± 50 mA
Max Junction Temp (T_J)	+150°C
Thermal Resistance (θ_{JA})	30°C/W
ESD Rating	
Human Body Model (Note 6)	2500V
Machine Model (Note 6)	250V
Storage Temperature	-65°C to +150°C

Soldering process must comply with National Semiconductor's Reflow Temperature Profile specifications. Refer to www.national.com/packaging. (Note 7)

Operating Ratings (Notes 1, 3)

Operating Temperature	$-40^\circ\text{C} \leq T_A \leq +85^\circ\text{C}$
Supply Voltage (V_A)	+2.7V to +3.6V
Output Driver Supply (V_{DR})	+2.4V to V_A
Clock Duty Cycle	
(DCS Enabled)	30/70 %
(DCS Disabled)	45/55 %
V_{CM}	1.4V to 1.6V
IAGND-DRGNDI	$\leq 100\text{mV}$

Converter Electrical Characteristics

Unless otherwise specified, the following specifications apply: AGND = DRGND = 0V, $V_A = +3.3V$, $V_{DR} = +2.5V$, Internal $V_{REF} = +1.2V$, $f_{CLK} = 105$ MHz, $V_{CM} = V_{CMO}$, $C_L = 5$ pF/pin. Typical values are for $T_A = 25^\circ\text{C}$. **Boldface limits apply for $T_{MIN} \leq T_A \leq T_{MAX}$.** All other limits apply for $T_A = 25^\circ\text{C}$ (Notes 8, 9)

Symbol	Parameter	Conditions	Typical (Note 10)	Limits	Units (Limits)
STATIC CONVERTER CHARACTERISTICS					
	Resolution with No Missing Codes			12	Bits (min)
INL	Integral Non Linearity (Note 11)		± 0.5	1.1 -1.1	LSB (max) LSB (min)
DNL	Differential Non Linearity		± 0.2	0.55 -0.55	LSB (max) LSB (min)
PGE	Positive Gain Error		-0.1	± 1	%FS (max)
NGE	Negative Gain Error		0.18	± 1	%FS (max)
TC PGE	Positive Gain Error Tempco	$-40^\circ\text{C} \leq T_A \leq +85^\circ\text{C}$	-3		ppm/°C
TC NGE	Negative Gain Error Tempco	$-40^\circ\text{C} \leq T_A \leq +85^\circ\text{C}$	-7		ppm/°C
V_{OFF}	Offset Error		0.01	± 0.55	%FS (max)
TC V_{OFF}	Offset Error Tempco	$-40^\circ\text{C} \leq T_A \leq +85^\circ\text{C}$	-4		ppm/°C
	Under Range Output Code		0	0	
	Over Range Output Code		4095	4095	
REFERENCE AND ANALOG INPUT CHARACTERISTICS					
V_{CMO}	Common Mode Output Voltage		1.5	1.45 1.56	V (min) V (max)
V_{CM}	Analog Input Common Mode Voltage		1.5	1.4 1.6	V (min) V (max)
C_{IN}	V_{IN} Input Capacitance (each pin to GND) (Note 12)	$V_{IN} = 1.5$ Vdc ± 0.5 V	(CLK LOW)	8.5	pF
			(CLK HIGH)	3.5	pF
V_{REF}	Internal Reference Voltage		1.2	1.176 1.224	V (min) V (max)
TC V_{REF}	Internal Reference Voltage Tempco	$-40^\circ\text{C} \leq T_A \leq +85^\circ\text{C}$	18		ppm/°C
V_{RP}	Internal Reference Top		2		V
V_{RN}	Internal Reference Bottom		1		V

Symbol	Parameter	Conditions	Typical (Note 10)	Limits	Units (Limits)
	Internal Reference Accuracy	$(V_{RP}-V_{RN})$	1	0.89 1.06	V (Min) V (max)
EXTV _{REF}	External Reference Voltage		1.20	1.176 1.224	V (min) V (max)

Dynamic Converter Electrical Characteristics

Unless otherwise specified, the following specifications apply: AGND = DRGND = 0V, $V_A = +3.3V$, $V_{DR} = +2.5V$, Internal $V_{REF} = +1.2V$, $f_{CLK} = 105\text{ MHz}$, $V_{CM} = V_{CMO}$, $C_L = 5\text{ pF/pin}$, . Typical values are for $T_A = 25^\circ\text{C}$. **Boldface limits apply for $T_{MIN} \leq T_A \leq T_{MAX}$.** All other limits apply for $T_A = 25^\circ\text{C}$ (Notes 3, 1)

Symbol	Parameter	Conditions	Typical (Note 10)	Limits	Units (Limits) (Note 2)
--------	-----------	------------	----------------------	--------	-------------------------------

DYNAMIC CONVERTER CHARACTERISTICS, $A_{IN} = -1\text{dBFS}$

FPBW	Full Power Bandwidth	-1 dBFS Input, -3 dB Corner	1.0		GHz
SNR	Signal-to-Noise Ratio	$f_{IN} = 10\text{ MHz}$	71		dBFS
		$f_{IN} = 70\text{ MHz}$	70.5		dBFS
		$f_{IN} = 170\text{ MHz}$	69.1	68	dBFS
		$f_{IN} = 240\text{ MHz}$	68.5		dBFS
SFDR	Spurious Free Dynamic Range	$f_{IN} = 10\text{ MHz}$	90		dBFS
		$f_{IN} = 70\text{ MHz}$	86		dBFS
		$f_{IN} = 170\text{ MHz}$	83	78	dBFS
		$f_{IN} = 240\text{ MHz}$	81		dBFS
ENOB	Effective Number of Bits	$f_{IN} = 10\text{ MHz}$	11.5		Bits
		$f_{IN} = 70\text{ MHz}$	11.4		Bits
		$f_{IN} = 170\text{ MHz}$	11.2	10.9	Bits
		$f_{IN} = 240\text{ MHz}$	11		dBFS
THD	Total Harmonic Distortion	$f_{IN} = 10\text{ MHz}$	-86		dBFS
		$f_{IN} = 70\text{ MHz}$	-85		dBFS
		$f_{IN} = 170\text{ MHz}$	-84	-76.5	dBFS
		$f_{IN} = 240\text{ MHz}$	-80		dBFS
H2	Second Harmonic Distortion	$f_{IN} = 10\text{ MHz}$	-95		dBFS
		$f_{IN} = 70\text{ MHz}$	-90		dBFS
		$f_{IN} = 170\text{ MHz}$	-83	-78	dBFS
		$f_{IN} = 240\text{ MHz}$	-84		dBFS
H3	Third Harmonic Distortion	$f_{IN} = 10\text{ MHz}$	-90		dBFS
		$f_{IN} = 70\text{ MHz}$	-86		dBFS
		$f_{IN} = 170\text{ MHz}$	-83	-78	dBFS
		$f_{IN} = 240\text{ MHz}$	-81		dBFS
SINAD	Signal-to-Noise and Distortion Ratio	$f_{IN} = 10\text{ MHz}$	70.9		dBFS
		$f_{IN} = 70\text{ MHz}$	70.3		dBFS
		$f_{IN} = 170\text{ MHz}$	69	67.4	dBFS
		$f_{IN} = 240\text{ MHz}$	68.2		dBFS
IMD	Intermodulation Distortion	$f_{IN} = 20\text{ MHz}$ and 21 MHz , each -7dBFS	-84		dBFS
	Crosstalk	0 MHz tested channel, $f_{IN} = 10\text{ MHz}$ at -1dBFS other channel	-100		dBFS

Logic and Power Supply Electrical Characteristics

Unless otherwise specified, the following specifications apply: AGND = DRGND = 0V, $V_A = +3.3V$, $V_{DR} = +2.5V$, Internal $V_{REF} = +1.2V$, $f_{CLK} = 105\text{ MHz}$, $V_{CM} = V_{CMO}$, $C_L = 5\text{ pF/pin}$. Typical values are for $T_A = 25^\circ\text{C}$. **Boldface limits apply for $T_{MIN} \leq T_A \leq T_{MAX}$** . All other limits apply for $T_A = 25^\circ\text{C}$ (Notes 8, 9)

Symbol	Parameter	Conditions	Typical (Note 10)	Limits	Units (Limits)
DIGITAL INPUT CHARACTERISTICS (CLK, PD_A, PD_B)					
$V_{IN(1)}$	Logical "1" Input Voltage	$V_D = 3.3V$		2.0	V (min)
$V_{IN(0)}$	Logical "0" Input Voltage	$V_D = 3.0V$		0.8	V (max)
$I_{IN(1)}$	Logical "1" Input Current	$V_{IN} = 3.3V$	10		μA
$I_{IN(0)}$	Logical "0" Input Current	$V_{IN} = 0V$	-10		μA
C_{IN}	Digital Input Capacitance		5		pF
DIGITAL OUTPUT CHARACTERISTICS (DA0-DA11, DB0-DB11, DRDY)					
$V_{OUT(1)}$	Logical "1" Output Voltage	$I_{OUT} = -0.5\text{ mA}$, $V_{DR} = 2.4V$		2.0	V (min)
$V_{OUT(0)}$	Logical "0" Output Voltage	$I_{OUT} = 1.6\text{ mA}$, $V_{DR} = 2.4V$		0.4	V (max)
$+I_{SC}$	Output Short Circuit Source Current	$V_{OUT} = 0V$	-10		mA
$-I_{SC}$	Output Short Circuit Sink Current	$V_{OUT} = V_{DR}$	10		mA
C_{OUT}	Digital Output Capacitance		5		pF
POWER SUPPLY CHARACTERISTICS					
I_A	Analog Supply Current	Full Operation	242	273	mA (max)
I_{DR}	Digital Output Supply Current	Full Operation (Note 13)	32		mA
	Power Consumption	Excludes I_{DR} (Note 13)	800	900	mW (max)
	Power Down Power Consumption	$PD_A = PD_B = V_A$	33		mW

Timing and AC Characteristics

查询"ADC12DC105"供应商

Unless otherwise specified, the following specifications apply: AGND = DRGND = 0V, $V_A = +3.3V$, $V_{DR} = +2.5V$, Internal $V_{REF} = +1.2V$, $f_{CLK} = 105\text{ MHz}$, $V_{CM} = V_{CMO}$, $C_L = 5\text{ pF/pin}$. Typical values are for $T_A = 25^\circ\text{C}$. Timing measurements are taken at 50% of the signal amplitude. **Boldface limits apply for $T_{MIN} \leq T_A \leq T_{MAX}$** . All other limits apply for $T_A = 25^\circ\text{C}$ (Notes 8, 9)

Symb	Parameter	Conditions	Typical (Note 10)	Limits	Units (Limits)
	Maximum Clock Frequency			105	MHz (max)
	Minimum Clock Frequency			20	MHz (min)
t_{CH}	Clock High Time		4		ns
t_{CL}	Clock Low Time		4		ns
t_{CONV}	Conversion Latency			7	Clock Cycles
t_{OD}	Output Delay of CLK to DATA	Relative to rising edge of CLK	6.7	4.6 8.8	ns (min) ns (max)
t_{SU}	Data Output Setup Time	Relative to DRDY	4	3	ns (min)
t_H	Data Output Hold Time	Relative to DRDY	5.5	3.8	ns (min)
t_{AD}	Aperture Delay		0.6		ns
t_{AJ}	Aperture Jitter		0.1		ps rms

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is guaranteed to be functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions. Operation of the device beyond the maximum Operating Ratings is not recommended.

Note 2: This parameter is specified in units of dBFS - indicating the value that would be attained with a full-scale input signal.

Note 3: All voltages are measured with respect to GND = AGND = DRGND = 0V, unless otherwise specified.

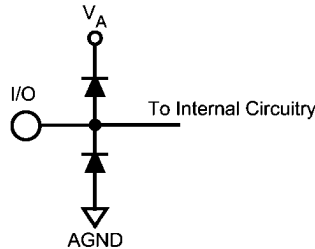
Note 4: When the input voltage at any pin exceeds the power supplies (that is, $V_{IN} < \text{AGND}$, or $V_{IN} > V_A$), the current at that pin should be limited to $\pm 5\text{ mA}$. The $\pm 50\text{ mA}$ maximum package input current rating limits the number of pins that can safely exceed the power supplies with an input current of $\pm 5\text{ mA}$ to 10.

Note 5: The maximum allowable power dissipation is dictated by $T_{J,max}$, the junction-to-ambient thermal resistance, (θ_{JA}), and the ambient temperature, (T_A), and can be calculated using the formula $P_{D,max} = (T_{J,max} - T_A) / \theta_{JA}$. The values for maximum power dissipation listed above will be reached only when the device is operated in a severe fault condition (e.g. when input or output pins are driven beyond the power supply voltages, or the power supply polarity is reversed). Such conditions should always be avoided.

Note 6: Human Body Model is 100 pF discharged through a 1.5 k Ω resistor. Machine Model is 220 pF discharged through 0 Ω .

Note 7: Reflow temperature profiles are different for lead-free and non-lead-free packages.

Note 8: The inputs are protected as shown below. Input voltage magnitudes above V_A or below GND will not damage this device, provided current is limited per (Note 4). However, errors in the A/D conversion can occur if the input goes above 2.6V or below GND as described in the Operating Ratings section.



30073911

Note 9: With a full scale differential input of $2V_{P-P}$, the 12-bit LSB is 488 μV .

Note 10: Typical figures are at $T_A = 25^\circ\text{C}$ and represent most likely parametric norms at the time of product characterization. The typical specifications are not guaranteed.

Note 11: Integral Non Linearity is defined as the deviation of the analog value, expressed in LSBs, from the straight line that passes through positive and negative full-scale.

Note 12: The input capacitance is the sum of the package/pin capacitance and the sample and hold circuit capacitance.

Note 13: I_{DR} is the current consumed by the switching of the output drivers and is primarily determined by load capacitance on the output pins, the supply voltage, V_{DR} , and the rate at which the outputs are switching (which is signal dependent). $I_{DR} = V_{DR}(C_0 \times f_0 + C_1 \times f_1 + \dots + C_{11} \times f_{11})$ where V_{DR} is the output driver power supply voltage, C_n is total capacitance on the output pin, and f_n is the average frequency at which that pin is toggling.

Note 14: This parameter is guaranteed by design and/or characterization and is not tested in production.

Specification Definitions

查询"ADC12DC105"供应商

APERTURE DELAY is the time after the falling edge of the clock to when the input signal is acquired or held for conversion.

APERTURE JITTER (APERTURE UNCERTAINTY) is the variation in aperture delay from sample to sample. Aperture jitter manifests itself as noise in the output.

CLOCK DUTY CYCLE is the ratio of the time during one cycle that a repetitive digital waveform is high to the total time of one period. The specification here refers to the ADC clock input signal.

COMMON MODE VOLTAGE (V_{CM}) is the common DC voltage applied to both input terminals of the ADC.

CONVERSION LATENCY is the number of clock cycles between initiation of conversion and when that data is presented to the output driver stage. Data for any given sample is available at the output pins the Pipeline Delay plus the Output Delay after the sample is taken. New data is available at every clock cycle, but the data lags the conversion by the pipeline delay.

CROSSTALK is coupling of energy from one channel into the other channel.

DIFFERENTIAL NON-LINEARITY (DNL) is the measure of the maximum deviation from the ideal step size of 1 LSB.

EFFECTIVE NUMBER OF BITS (ENOB, or EFFECTIVE BITS) is another method of specifying Signal-to-Noise and Distortion Ratio or SINAD. ENOB is defined as $(\text{SINAD} - 1.76) / 6.02$ and says that the converter is equivalent to a perfect ADC of this (ENOB) number of bits.

FULL POWER BANDWIDTH is a measure of the frequency at which the reconstructed output fundamental drops 3 dB below its low frequency value for a full scale input.

GAIN ERROR is the deviation from the ideal slope of the transfer function. It can be calculated as:

$$\text{Gain Error} = \text{Positive Full Scale Error} - \text{Negative Full Scale Error}$$

It can also be expressed as Positive Gain Error and Negative Gain Error, which are calculated as:

$$\begin{aligned} \text{PGE} &= \text{Positive Full Scale Error} - \text{Offset Error} \\ \text{NGE} &= \text{Offset Error} - \text{Negative Full Scale Error} \end{aligned}$$

INTEGRAL NON LINEARITY (INL) is a measure of the deviation of each individual code from a best fit straight line. The deviation of any given code from this straight line is measured from the center of that code value.

INTERMODULATION DISTORTION (IMD) is the creation of additional spectral components as a result of two sinusoidal frequencies being applied to the ADC input at the same time. It is defined as the ratio of the power in the intermodulation products to the total power in the original frequencies. IMD is usually expressed in dBFS.

LSB (LEAST SIGNIFICANT BIT) is the bit that has the smallest value or weight of all bits. This value is $V_{FS}/2^n$, where " V_{FS} " is the full scale input voltage and " n " is the ADC resolution in bits.

MISSING CODES are those output codes that will never appear at the ADC outputs. The ADC is guaranteed not to have any missing codes.

MSB (MOST SIGNIFICANT BIT) is the bit that has the largest value or weight. Its value is one half of full scale.

NEGATIVE FULL SCALE ERROR is the difference between the actual first code transition and its ideal value of $\frac{1}{2}$ LSB above negative full scale.

OFFSET ERROR is the difference between the two input voltages $[(V_{IN+}) - (V_{IN-})]$ required to cause a transition from code 2047 to 2048.

OUTPUT DELAY is the time delay after the falling edge of the clock before the data update is presented at the output pins.

PIPELINE DELAY (LATENCY) See CONVERSION LATENCY.

POSITIVE FULL SCALE ERROR is the difference between the actual last code transition and its ideal value of $\frac{1}{2}$ LSB below positive full scale.

POWER SUPPLY REJECTION RATIO (PSRR) is a measure of how well the ADC rejects a change in the power supply voltage. PSRR is the ratio of the Full-Scale output of the ADC with the supply at the minimum DC supply limit to the Full-Scale output of the ADC with the supply at the maximum DC supply limit, expressed in dB.

SIGNAL TO NOISE RATIO (SNR) is the ratio, expressed in dB, of the rms value of the input signal to the rms value of the sum of all other spectral components below one-half the sampling frequency, not including harmonics or DC.

SIGNAL TO NOISE PLUS DISTORTION (S/N+D or SINAD) Is the ratio, expressed in dB, of the rms value of the input signal to the rms value of all of the other spectral components below half the clock frequency, including harmonics but excluding d.c.

SPURIOUS FREE DYNAMIC RANGE (SFDR) is the difference, expressed in dB, between the rms values of the input signal and the peak spurious signal, where a spurious signal is any signal present in the output spectrum that is not present at the input.

TOTAL HARMONIC DISTORTION (THD) is the ratio, expressed in dB, of the rms total of the first six harmonic levels at the output to the level of the fundamental at the output. THD is calculated as:

$$\text{THD} = 20 \times \log \sqrt{\frac{f_2^2 + \dots + f_7^2}{f_1^2}}$$

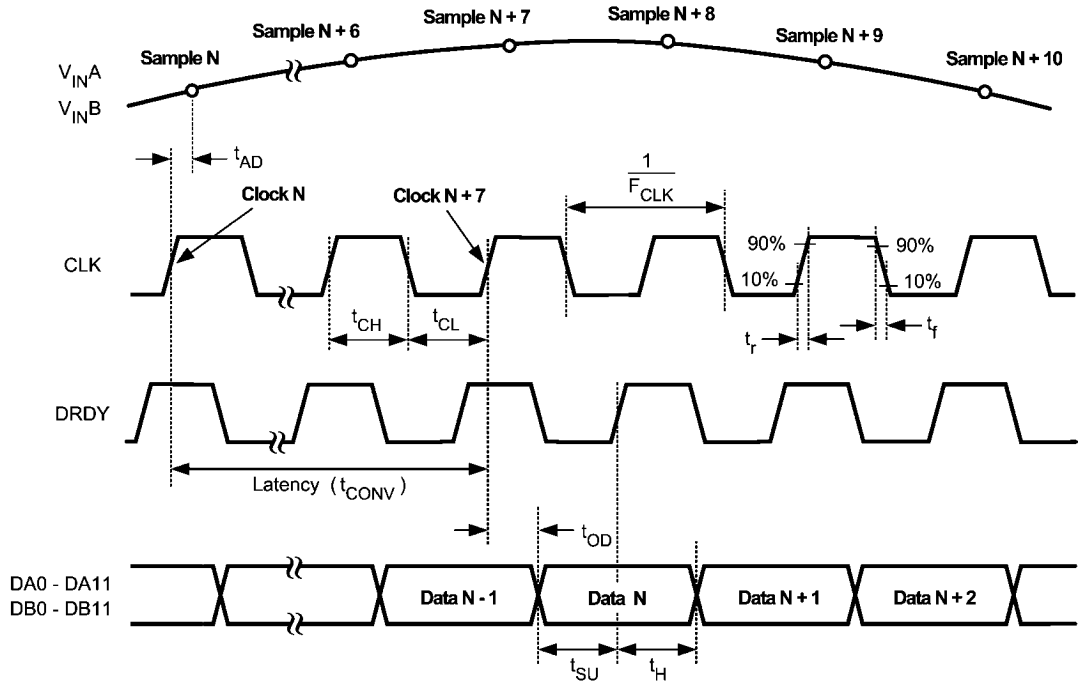
where f_1 is the RMS power of the fundamental (output) frequency and f_2 through f_7 are the RMS power of the first 6 harmonic frequencies in the output spectrum.

SECOND HARMONIC DISTORTION (2ND HARM) is the difference expressed in dB, between the RMS power in the input frequency at the output and the power in its 2nd harmonic level at the output.

THIRD HARMONIC DISTORTION (3RD HARM) is the difference, expressed in dB, between the RMS power in the input frequency at the output and the power in its 3rd harmonic level at the output.

Timing Diagrams

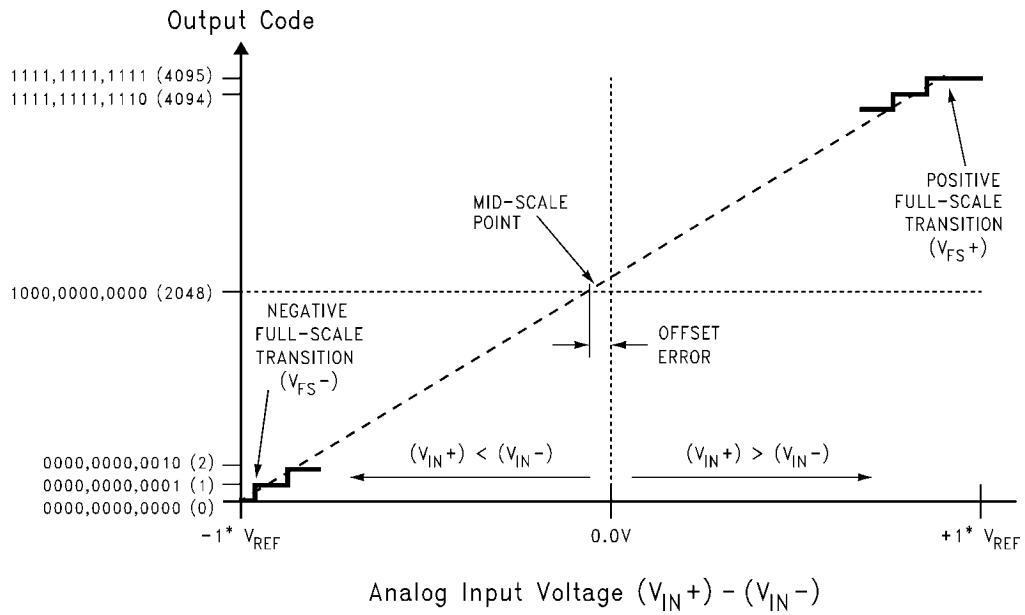
查询"ADC12DC105"供应商



30073909

FIGURE 1. Output Timing

Transfer Characteristic

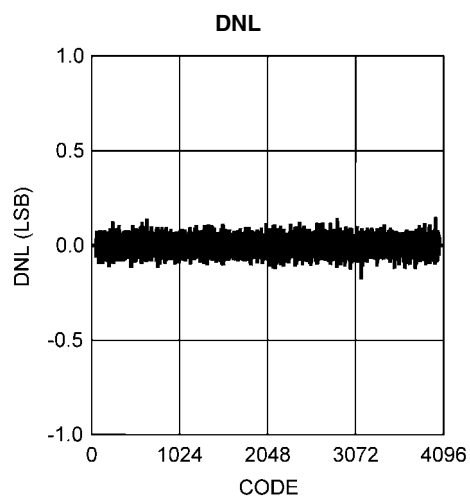


30073910

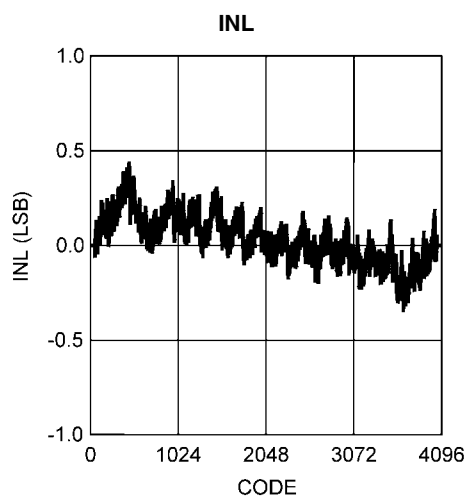
FIGURE 2. Transfer Characteristic

Typical Performance Characteristics DNL, INL

Unless otherwise specified, the following specifications are for $V_A = +3.3V$, $V_{DR} = +2.5V$, Internal $V_{REF} = +1.2V$, $f_{CLK} = 105\text{ MHz}$, 50% Duty Cycle, DCS disabled, $V_{CM} = V_{CMO}$, $T_A = 25^\circ\text{C}$.



30073941

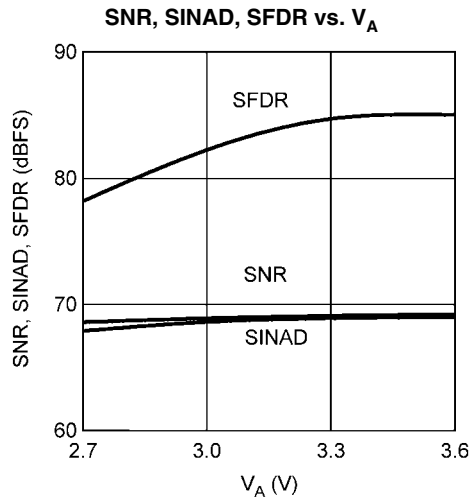


30073942

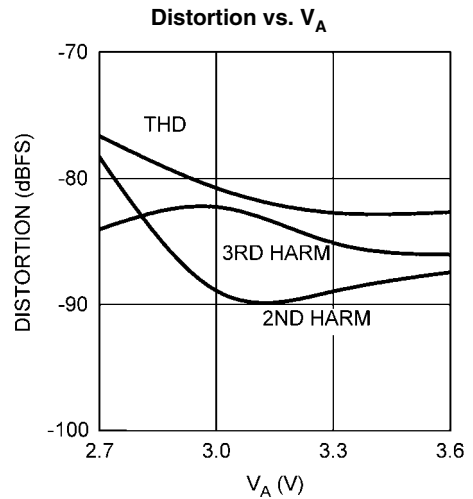
Typical Performance Characteristics

查询"ADC12DC105"供应商

Unless otherwise specified, the following specifications apply:
 $V_{CM} = 0.8V$, $V_A = 3.3V$, $V_{DR} = +2.5V$, Internal $V_{REF} = +1.2V$, $f_{CLK} = 105\text{ MHz}$, 50% Duty Cycle, DCS disabled, $V_{CM} = 0.8V$, $f_{IN} = 170\text{ MHz}$, $T_A = 25^\circ\text{C}$.

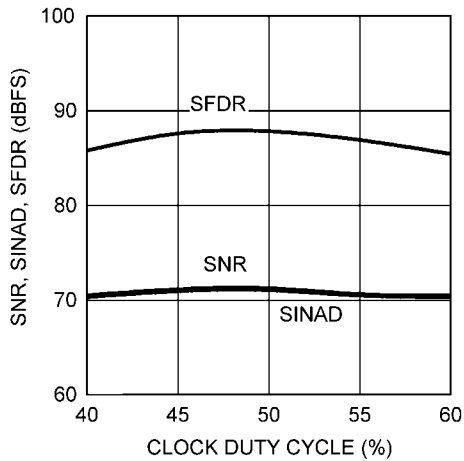


30073951



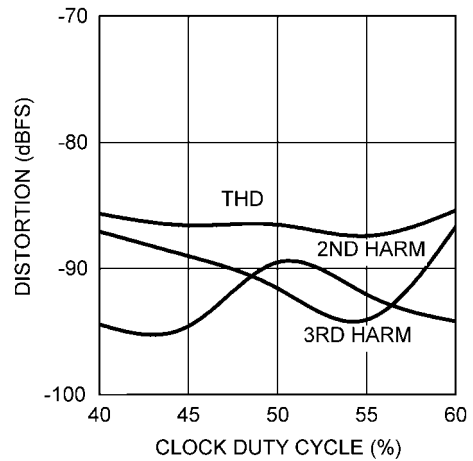
30073952

SNR, SINAD, SFDR vs. Clock Duty Cycle, $f_{IN}=40\text{ MHz}$



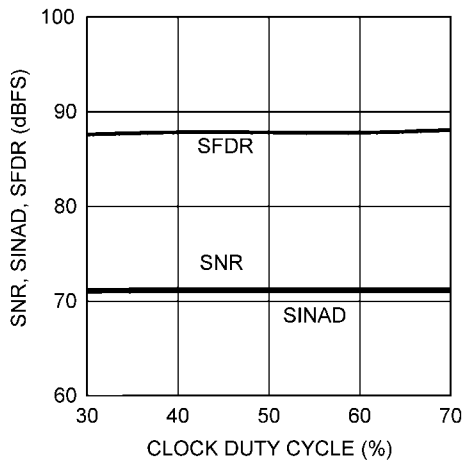
30073957

Distortion vs. Clock Duty Cycle, $f_{IN}=40\text{ MHz}$



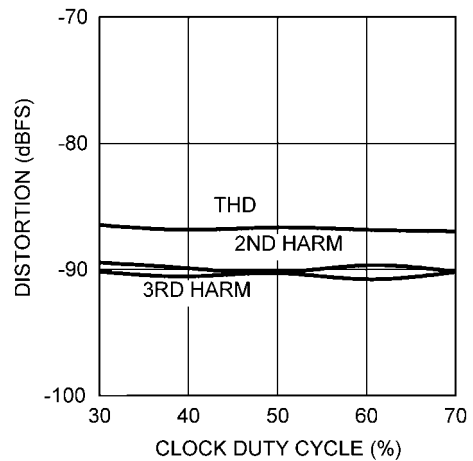
30073958

SNR, SINAD, SFDR vs. Clock Duty Cycle, DCS Enabled, $f_{IN}=40\text{ MHz}$



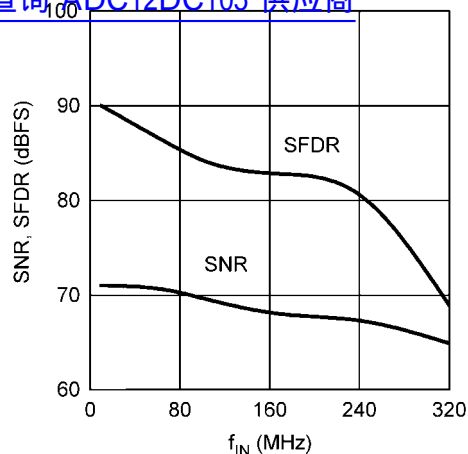
30073959

Distortion vs. Clock Duty Cycle, DCS Enabled, $f_{IN}=40\text{ MHz}$



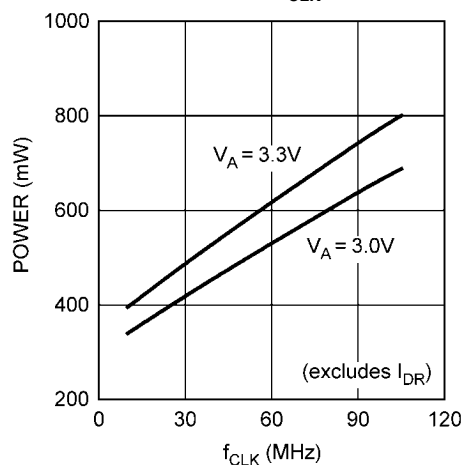
30073960

SNR and SFDR vs. f_{IN}
[查询"ADC12DC105"供应商](#)



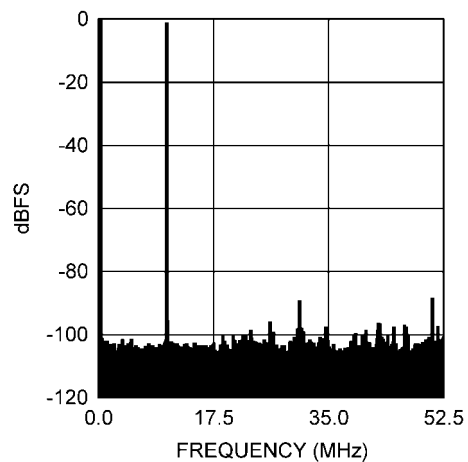
30073978

POWER vs. f_{CLK}



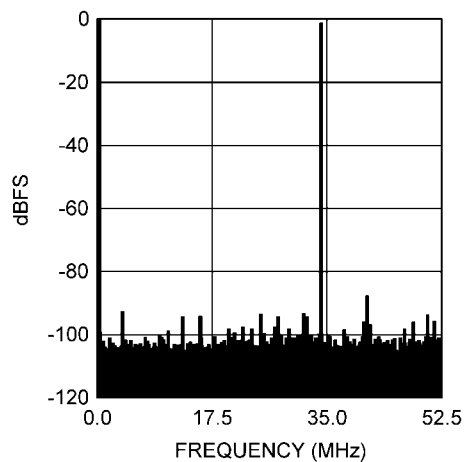
30073976

Spectral Response @ 10 MHz Input



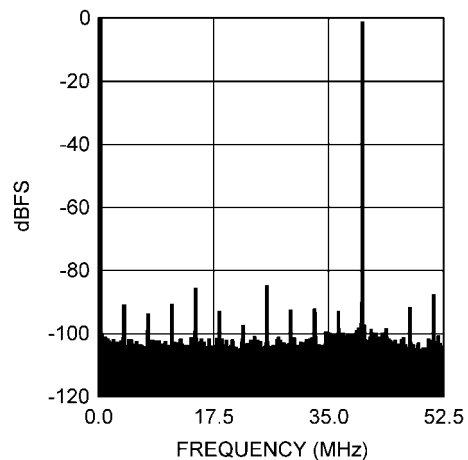
30073968

Spectral Response @ 70 MHz Input



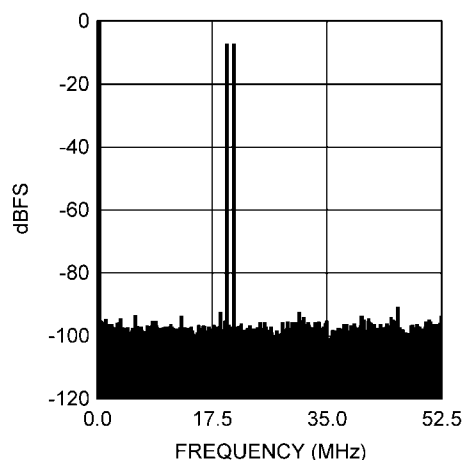
30073969

Spectral Response @ 170 MHz Input



30073970

IMD, $f_{IN1} = 20$ MHz, $f_{IN2} = 21$ MHz



30073971

Functional Description

查询"ADC12DC105"供应商

Operating on a single +3.0V or +3.3V supply, the ADC12DC105 digitizes two differential analog input signals to 12 bits, using a differential pipelined architecture with error correction circuitry and an on-chip sample-and-hold circuit to ensure maximum performance. The user has the choice of using an internal 1.2V stable reference, or using an external 1.2V reference. Any external reference is buffered on-chip to ease the task of driving that pin. Duty cycle stabilization and output data format are selectable using the quad state function OF/DCS pin (pin 19). The output data can be set for offset binary or two's complement.

Applications Information

1.0 OPERATING CONDITIONS

We recommend that the following conditions be observed for operation of the ADC12DC105:

$$2.7V \leq V_A \leq 3.6V$$

$$2.4V \leq V_{DR} \leq V_A$$

$$20 \text{ MHz} \leq f_{CLK} \leq 105 \text{ MHz}$$

1.2V internal reference

$$V_{REF} = 1.2V \text{ (for an external reference)}$$

$$V_{CM} = 1.5V \text{ (from } V_{CMO})$$

2.0 ANALOG INPUTS

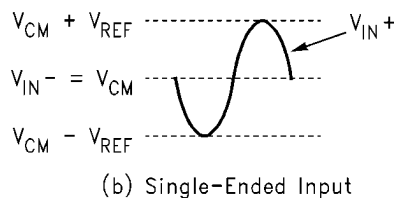
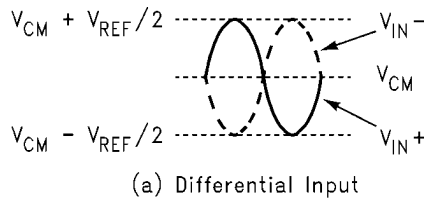
2.1 Signal Inputs

2.1.1 Differential Analog Input Pins

The ADC12DC105 has a pair of analog signal input pins for each of two channels. V_{IN+} and V_{IN-} form a differential input pair. The input signal, V_{IN} , is defined as:

$$V_{IN} = (V_{IN+}) - (V_{IN-})$$

Figure 3 shows the expected input signal range. Note that the common mode input voltage, V_{CM} , should be 1.5V. Using V_{CMO} (pins 7,9) for V_{CM} will ensure the proper input common mode level for the analog input signal. The positive peaks of the individual input signals should each never exceed 2.6V. Each analog input pin of the differential pair should have a maximum peak-to-peak voltage of 1V, be 180° out of phase with each other and be centered around V_{CM} . The peak-to-peak voltage swing at each analog input pin should not exceed the 1V or the output data will be clipped.



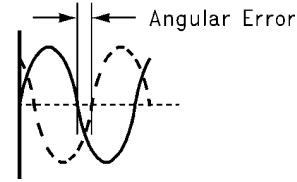
30073980

FIGURE 3. Expected Input Signal Range

For single frequency sine waves the full scale error in LSB can be described as approximately:

$$E_{FS} = 4096 (1 - \sin(90^\circ + \text{dev}))$$

Where dev is the angular difference in degrees between the two signals having a 180° relative phase relationship to each other (see Figure 4). For single frequency inputs, angular errors result in a reduction of the effective full scale input. For complex waveforms, however, angular errors will result in distortion.



30073981

FIGURE 4. Angular Errors Between the Two Input Signals Will Reduce the Output Level or Cause Distortion

It is recommended to drive the analog inputs with a source impedance less than 100Ω. Matching the source impedance for the differential inputs will improve even ordered harmonic performance (particularly second harmonic).

Table 1 indicates the input to output relationship of the ADC12DC105.

[查询"ADC12DC105"供应商](#)

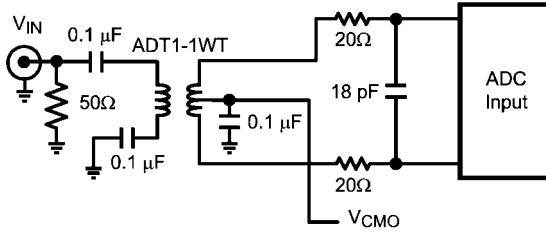
TABLE 1. Input to Output Relationship

V_{IN+}	V_{IN-}	Binary Output	2's Complement Output	
$V_{CM} - V_{REF}/2$	$V_{CM} + V_{REF}/2$	00 0000 0000 00	10 0000 0000 00	Negative Full-Scale
$V_{CM} - V_{REF}/4$	$V_{CM} + V_{REF}/4$	01 0000 0000 00	11 0000 0000 00	
V_{CM}	V_{CM}	10 0000 0000 00	00 0000 0000 00	Mid-Scale
$V_{CM} + V_{REF}/4$	$V_{CM} - V_{REF}/4$	11 0000 0000 00	01 0000 0000 00	
$V_{CM} + V_{REF}/2$	$V_{CM} - V_{REF}/2$	11 1111 1111 11	01 1111 1111 11	Positive Full-Scale

2.1.2 Driving the Analog Inputs

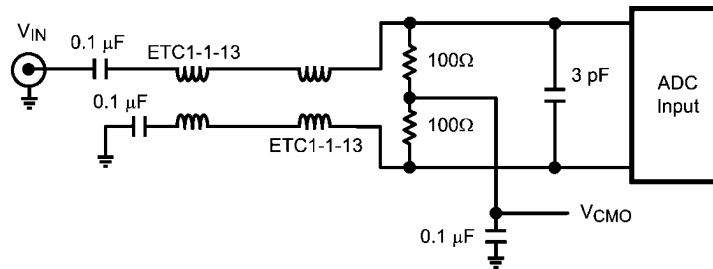
The V_{IN+} and the V_{IN-} inputs of the ADC12DC105 have an internal sample-and-hold circuit which consists of an analog switch followed by a switched-capacitor amplifier.

Figure 5 and Figure 6 show examples of single-ended to differential conversion circuits. The circuit in Figure 5 works well for input frequencies up to approximately 70MHz, while the circuit in Figure 6 works well above 70MHz.



30073982

FIGURE 5. Low Input Frequency Transformer Drive Circuit



30073983

FIGURE 6. High Input Frequency Transformer Drive Circuit

One short-coming of using a transformer to achieve the single-ended to differential conversion is that most RF transformers have poor low frequency performance. A differential amplifier can be used to drive the analog inputs for low frequency applications. The amplifier must be fast enough to settle from the charging glitches on the analog input resulting from the sample-and-hold operation before the clock goes high and the sample is passed to the ADC core.

2.1.3 Input Common Mode Voltage

The input common mode voltage, V_{CM} , should be in the range of 1.4V to 1.6V and be a value such that the peak excursions of the analog signal do not go more negative than ground or more positive than 2.6V. It is recommended to use V_{CMO} (pins 7,9) as the input common mode voltage.

If the ADC12DC105 is operated with $V_A=3.6V$, a resistor of approximately 1KΩ should be used from the V_{CMO} pin to AGND. This will help maintain stability over the entire temperature range when using a high supply voltage.

2.2 Reference Pins

The ADC12DC105 is designed to operate with an internal or external 1.2V reference. The internal 1.2V reference is the default condition when no external reference input is applied to the V_{REF} pin. If a voltage is applied to the V_{REF} pin, then that voltage is used for the reference. The V_{REF} pin should always be bypassed to ground with a 0.1 μF capacitor close to the reference input pin. Do not load this pin when using the internal reference.

It is important that all grounds associated with the reference voltage and the analog input signal make connection to the ground plane at a single, quiet point to minimize the effects of noise currents in the ground path.

The Reference Bypass Pins (V_{RP} , V_{CMO} , and V_{RN}) for channels A and B are made available for bypass purposes. These pins should each be bypassed to AGND with a low ESL (equivalent series inductance) 0.1 μF capacitor placed very close to the pin to minimize stray inductance. A 0.1 μF capacitor should be placed between V_{RP} and V_{RN} as close to the pins as possible, and a 1 μF capacitor should be placed in parallel. This configuration is shown in Figure 7. It is nec-

essary to avoid reference oscillation, which could result in reduced SFDR and/or SNR. V_{REF} may be loaded to 1mA for use as a temperature stable 1.5V reference. The remaining pins should not be loaded.

Smaller capacitor values than those specified will allow faster recovery from the power down mode, but may result in degraded noise performance. Loading any of these pins, other than V_{CMO} may result in performance degradation.

The nominal voltages for the reference bypass pins are as follows:

$$V_{CMO} = 1.5 \text{ V}$$

$$V_{RP} = 2.0 \text{ V}$$

$$V_{RN} = 1.0 \text{ V}$$

2.3 OF/DCS Pin

Duty cycle stabilization and output data format are selectable using this quad state function pin. When enabled, duty cycle stabilization can compensate for clock inputs with duty cycles ranging from 30% to 70% and generate a stable internal clock, improving the performance of the part. With OF/DCS = V_A the output data format is 2's complement and duty cycle stabilization is not used. With OF/DCS = AGND the output data format is offset binary and duty cycle stabilization is not used. With OF/DCS = $(2/3) \cdot V_A$ the output data format is 2's complement and duty cycle stabilization is applied to the clock. If OF/DCS is $(1/3) \cdot V_A$ the output data format is offset binary and duty cycle stabilization is applied to the clock. While the sense of this pin may be changed "on the fly," doing this is not recommended as the output data could be erroneous for a few clock cycles after this change is made.

Note: This signal has no effect when SPI_EN is high and the serial control interface is enabled.

3.0 DIGITAL INPUTS

Digital CMOS compatible inputs consist of CLK, PD_A, and PD_B.

3.1 Clock Input

The CLK controls the timing of the sampling process. To achieve the optimum noise performance, the clock input should be driven with a stable, low jitter clock signal in the range indicated in the Electrical Table. The clock input signal should also have a short transition region. This can be achieved by passing a low-jitter sinusoidal clock source through a high speed buffer gate. The trace carrying the clock signal should be as short as possible and should not cross any other signal line, analog or digital, not even at 90°.

The clock signal also drives an internal state machine. If the clock is interrupted, or its frequency is too low, the charge on

the internal capacitors can dissipate to the point where the accuracy of the output data will degrade. This is what limits the minimum sample rate.

The clock line should be terminated at its source in the characteristic impedance of that line. Take care to maintain a constant clock line impedance throughout the length of the line. Refer to Application Note AN-905 for information on setting characteristic impedance.

It is highly desirable that the the source driving the ADC clock pins only drive that pin. However, if that source is used to drive other devices, then each driven pin should be AC terminated with a series RC to ground, such that the resistor value is equal to the characteristic impedance of the clock line and the capacitor value is:

$$C \geq \frac{4 \times t_{PD} \times L}{Z_0}$$

where t_{PD} is the signal propagation rate down the clock line, "L" is the line length and Z_0 is the characteristic impedance of the clock line. This termination should be as close as possible to the ADC clock pin but beyond it as seen from the clock source. Typical t_{PD} is about 150 ps/inch (60 ps/cm) on FR-4 board material. The units of "L" and t_{PD} should be the same (inches or centimeters).

The duty cycle of the clock signal can affect the performance of the A/D Converter. Because achieving a precise duty cycle is difficult, the ADC12DC105 has a Duty Cycle Stabilizer.

4.0 DIGITAL OUTPUTS

Digital outputs consist of the CMOS signals DA0-DA11, DB0-DB11, and DRDY.

The ADC12DC105 has 12 CMOS compatible data output pins corresponding to the converted input value for each channel, and a data ready (DRDY) signal that should be used to capture the output data. Valid data is present at these outputs while the PD pin is low. Data should be captured and latched with the rising edge of the DRDY signal.

Be very careful when driving a high capacitance bus. The more capacitance the output drivers must charge for each conversion, the more instantaneous digital current flows through V_{DR} and DRGND. These large charging current spikes can cause on-chip ground noise and couple into the analog circuitry, degrading dynamic performance. Adequate bypassing, limiting output capacitance and careful attention to the ground plane will reduce this problem. The result could be an apparent reduction in dynamic performance.



FIGURE 7. Application Circuit

5.0 POWER SUPPLY CONSIDERATIONS

查询"ADC12DC105"供应商

The ADC12DC105 should be bypassed with a 0.1 μF capacitor and with a 100 pF ceramic chip capacitor close to each power pin. Leadless chip capacitors are preferred because they have low series inductance.

As is the case with all high-speed converters, the ADC12DC105 is sensitive to power supply noise. Accordingly, the noise on the analog supply pin should be kept below 100 mV_{P-P}.

No pin should ever have a voltage on it that is in excess of the supply voltages, not even on a transient basis. Be especially careful of this during power turn on and turn off.

6.0 LAYOUT AND GROUNDING

Proper grounding and proper routing of all signals are essential to ensure accurate conversion. Maintaining separate analog and digital areas of the board, with the ADC12DC105 between these areas, is required to achieve specified performance.

Capacitive coupling between the typically noisy digital circuitry and the sensitive analog circuitry can lead to poor performance. The solution is to keep the analog circuitry separated from the digital circuitry, and to keep the clock line as short as possible.

Since digital switching transients are composed largely of high frequency components, total ground plane copper weight will have little effect upon the logic-generated noise. This is because of the skin effect. Total surface area is more important than is total ground plane area.

Generally, analog and digital lines should cross each other at 90° to avoid crosstalk. To maximize accuracy in high speed, high resolution systems, however, avoid crossing analog and digital lines altogether. It is important to keep clock lines as short as possible and isolated from ALL other lines, including other digital lines. Even the generally accepted 90° crossing should be avoided with the clock line as even a little coupling can cause problems at high frequencies. This is because other lines can introduce jitter into the clock line, which can lead to degradation of SNR. Also, the high speed clock can introduce noise into the analog chain.

Best performance at high frequencies and at high resolution is obtained with a straight signal path. That is, the signal path through all components should form a straight line wherever possible.

Be especially careful with the layout of inductors and transformers. Mutual inductance can change the characteristics of the circuit in which they are used. Inductors and transformers should *not* be placed side by side, even with just a small part of their bodies beside each other. For instance, place transformers for the analog input and the clock input at 90° to one another to avoid magnetic coupling.

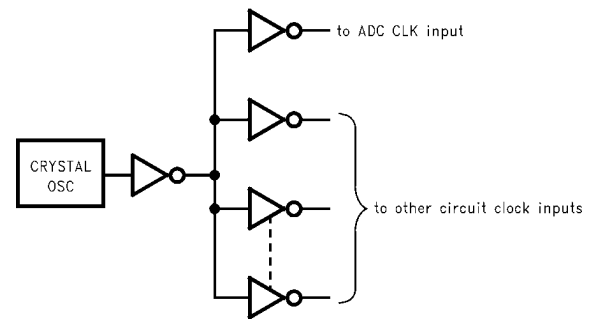
The analog input should be isolated from noisy signal traces to avoid coupling of spurious signals into the input. Any external component (e.g., a filter capacitor) connected between the converter's input pins and ground or to the reference input pin and ground should be connected to a very clean point in the ground plane.

All analog circuitry (input amplifiers, filters, reference components, etc.) should be placed in the analog area of the board. All digital circuitry and dynamic I/O lines should be placed in the digital area of the board. The ADC12DC105 should be between these two areas. Furthermore, all components in the reference circuitry and the input signal chain that are connected to ground should be connected together with short traces and enter the ground plane at a single, quiet point. All ground connections should have a low inductance path to ground.

7.0 DYNAMIC PERFORMANCE

To achieve the best dynamic performance, the clock source driving the CLK input must have a sharp transition region and be free of jitter. Isolate the ADC clock from any digital circuitry with buffers, as with the clock tree shown in *Figure 8*. The gates used in the clock tree must be capable of operating at frequencies much higher than those used if added jitter is to be prevented.

As mentioned in Section 3.1 *Clock Input*, it is good practice to keep the ADC clock line as short as possible and to keep it well away from any other signals. Other signals can introduce jitter into the clock signal, which can lead to reduced SNR performance, and the clock can introduce noise into other lines. Even lines with 90° crossings have capacitive coupling, so try to avoid even these 90° crossings of the clock line.

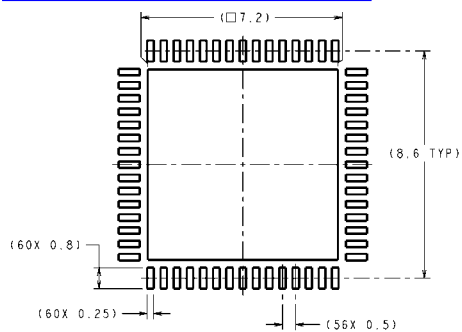


30073986

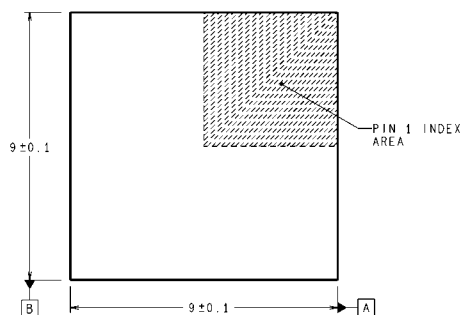
FIGURE 8. Isolating the ADC Clock from other Circuitry with a Clock Tree

Physical Dimensions inches (millimeters) unless otherwise noted

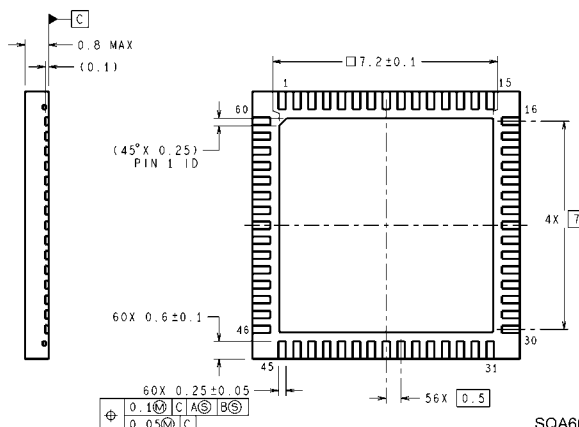
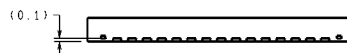
[查询"ADC12DC105"供应商](#)



RECOMMENDED LAND PATTERN



DIMENSIONS ARE IN MILLIMETERS
DIMENSION IN () FOR REFERENCE ONLY



SQA60A (Rev A)

TOP View.....SIDE View.....BOTTOM View

60-Lead LLP Package
Ordering Number:
ADC12DC105CISQ
NS Package Number SQA60A

[查询"ADC12DC105"供应商](#)

Notes

For more National Semiconductor product information and proven design tools, visit the following Web sites at:

Products		Design Support	
Amplifiers	www.national.com/amplifiers	WEBENCH	www.national.com/webench
Audio	www.national.com/audio	Analog University	www.national.com/AU
Clock Conditioners	www.national.com/timing	App Notes	www.national.com/appnotes
Data Converters	www.national.com/adc	Distributors	www.national.com/contacts
Displays	www.national.com/displays	Green Compliance	www.national.com/quality/green
Ethernet	www.national.com/ethernet	Packaging	www.national.com/packaging
Interface	www.national.com/interface	Quality and Reliability	www.national.com/quality
LVDS	www.national.com/lvds	Reference Designs	www.national.com/refdesigns
Power Management	www.national.com/power	Feedback	www.national.com/feedback
Switching Regulators	www.national.com/switchers		
LDOs	www.national.com/lido		
LED Lighting	www.national.com/led		
PowerWise	www.national.com/powerwise		
Serial Digital Interface (SDI)	www.national.com/sdi		
Temperature Sensors	www.national.com/tempsensors		
Wireless (PLL/VCO)	www.national.com/wireless		

THE CONTENTS OF THIS DOCUMENT ARE PROVIDED IN CONNECTION WITH NATIONAL SEMICONDUCTOR CORPORATION ("NATIONAL") PRODUCTS. NATIONAL MAKES NO REPRESENTATIONS OR WARRANTIES WITH RESPECT TO THE ACCURACY OR COMPLETENESS OF THE CONTENTS OF THIS PUBLICATION AND RESERVES THE RIGHT TO MAKE CHANGES TO SPECIFICATIONS AND PRODUCT DESCRIPTIONS AT ANY TIME WITHOUT NOTICE. NO LICENSE, WHETHER EXPRESS, IMPLIED, ARISING BY ESTOPPEL OR OTHERWISE, TO ANY INTELLECTUAL PROPERTY RIGHTS IS GRANTED BY THIS DOCUMENT.

TESTING AND OTHER QUALITY CONTROLS ARE USED TO THE EXTENT NATIONAL DEEMS NECESSARY TO SUPPORT NATIONAL'S PRODUCT WARRANTY. EXCEPT WHERE MANDATED BY GOVERNMENT REQUIREMENTS, TESTING OF ALL PARAMETERS OF EACH PRODUCT IS NOT NECESSARILY PERFORMED. NATIONAL ASSUMES NO LIABILITY FOR APPLICATIONS ASSISTANCE OR BUYER PRODUCT DESIGN. BUYERS ARE RESPONSIBLE FOR THEIR PRODUCTS AND APPLICATIONS USING NATIONAL COMPONENTS. PRIOR TO USING OR DISTRIBUTING ANY PRODUCTS THAT INCLUDE NATIONAL COMPONENTS, BUYERS SHOULD PROVIDE ADEQUATE DESIGN, TESTING AND OPERATING SAFEGUARDS.

EXCEPT AS PROVIDED IN NATIONAL'S TERMS AND CONDITIONS OF SALE FOR SUCH PRODUCTS, NATIONAL ASSUMES NO LIABILITY WHATSOEVER, AND NATIONAL DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY RELATING TO THE SALE AND/OR USE OF NATIONAL PRODUCTS INCLUDING LIABILITY OR WARRANTIES RELATING TO FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS PRIOR WRITTEN APPROVAL OF THE CHIEF EXECUTIVE OFFICER AND GENERAL COUNSEL OF NATIONAL SEMICONDUCTOR CORPORATION. As used herein:

Life support devices or systems are devices which (a) are intended for surgical implant into the body, or (b) support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in a significant injury to the user. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system or to affect its safety or effectiveness.

National Semiconductor and the National Semiconductor logo are registered trademarks of National Semiconductor Corporation. All other brand or product names may be trademarks or registered trademarks of their respective holders.

Copyright© 2008 National Semiconductor Corporation

For the most current product information visit us at www.national.com



**National Semiconductor
Americas Technical
Support Center**
Email: support@nsc.com
Tel: 1-800-272-9959

**National Semiconductor Europe
Technical Support Center**
Email: europe.support@nsc.com
German Tel: +49 (0) 180 5010 771
English Tel: +44 (0) 870 850 4288

**National Semiconductor Asia
Pacific Technical Support Center**
Email: ap.support@nsc.com

**National Semiconductor Japan
Technical Support Center**
Email: jpn.feedback@nsc.com